Communication

Superior performance of half-wave to full-wave rectifier as a power conditioning circuit for triboelectric nanogenerators: Application to contact-separation and sliding mode TENG

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ABSTRACT

In this brief communication the performance of a half-wave rectifier is compared with a full-wave rectifier as a conditioning circuit (CC) for a triboelectric nanogenerator (TENG) in providing electrical energy to a capacitive load. Contrary to the common understanding, it is shown that half-wave circuit provides a higher maximum energy to the capacitive load compared to full-wave. Formulas are provided to calculate the maximum energy delivered by the TENG to a capacitive load. Theoretical results show the enhanced performance of the half-wave CC compared to the full-wave. A TENG working in contact-separation mode is fabricated and tested with both CC’s and experimental results show a very good agreement with theoretical derivations, and confirm that half-wave CC provides a higher energy to the load compared to full-wave. The outcomes of this report should be useful for the researchers working on the development of CC’s for TENG’s.

1. Introduction

Triboelectric nanogenerators (TENG’s) are a promising technology to power-up low-power consumer electronics and medical devices [1, 2]. Such transducers have been developed for years and the research for developing new TENG’s is still going on [3, 4]. However, the output power of such transducers are still low and a huge interest exists for the design and development of new and enhanced conditioning circuits to boost the output performance of TENG’s [5, 6]. Conditioning circuits are an essential part of a kinetic energy conversion system that can control and amplify the flow of energy from one domain to another [7–9]. Usually, a CC for TENG include a rectifying circuit or element such as diodes and switches to convert the alternating output current of the device into a direct current that can be stored in a reservoir capacitance [9–11]. There are vast ranges of applications for TENG’s that are dependent to the implementation of conditioning circuits. Applications include self-powered electronic and photosynthetic bio-electronic sensors, green electronic skins, scavenging free energies from rain drops and water waves and body-heat energy converters, just to name a few among many examples [12–17].

Half-wave and full-wave rectifiers, among all, are the most widely used conditioning circuits in developing TENG. Therefore, several attempts have been made to enhance the performance of these two circuits. In [18], researchers tried adding serial and parallel switches in combination to a full-wave rectifier to enhance the output performance of a TENG. In [19], researchers mixed the full-wave rectifier with a transformer to boost the output power. In [20], a two stage logically-controlled switching system is used in combination with a full-wave rectifier and coupled inductors to manage the output power of the TENG. In [21], researchers employed a MOSFET switch controlled by a comparator as the next stage to a full-wave rectifier to manage the charge flow from the T-ENG. Nearly in all the cases, full-wave rectifier is chosen over the half-wave as a CC since it is believed by the researchers of the field that a full-wave CC delivers a higher energy to the load compared to the half-wave CC. In this short report, we will show that half-wave circuit delivers a higher energy per cycle of the operation of the TENG to a capacitive load compared to the full-wave rectifier. However, it should be noticed that the outcomes of this work are only applicable to the kinds of triboelectric nanogenerators that have variable capacitance values, such as contact-separation (CS) and...
2. Theoretical development

Fig. 1 shows a description of the contact-separation mode TENG and the two conditioning circuits under study. Two dielectric layers are attached onto the bottom electrode of the TENG that is fixed, and the top electrode is actuated by a magnetic shaker in the vertical direction with a sinusoidal excitation. As the top electrode touches the dielectric surface, negative triboelectric charges are generated on the surface and positive charges are induced on the top and bottom electrodes. The output ports of A and B of the TENG will be connected to the corresponding ports of the two conditioning circuits.

The total energy of the capacitor in the \(i\)th cycle is defined as

\[
W_i = 0.5CV_{i}^2
\]

and the converted energy during the \(i\)th cycle is defined as

\[
\Delta W_i = W_{i+1} - W_i
\]

In case the TENG is connected to the half-wave rectifier as in Fig. 1b, the converted energy can be formulised as [22] (Section S2 of supporting information):

\[
\Delta W_{i,HW} = V_{TE}V_{C_i}C_{max} \left(1 - \frac{1 + V_{C_i}/V_{TE}}{C_{max}/C_{min}}\right)
\]

where \(V_{TE}\) is the constant surface potential of the PFA (perfluoroalkoxy [23]) layer that can be derived by the technique introduced in [24]. \(C_{max}\) is the maximum capacitance between the top and bottom electrodes when the top electrode is in contact with the dielectric layer and \(C_{min}\) is the minimum capacitance when the air gap is at its maximum; the inequality \(C_{max} > C_{min}\) hold at all times. Both values of \(C_{max}\) and \(C_{min}\) can be calculated using the technique described in the supplementary material [25] (also see section S1 of supporting information). The parasitic capacitance of the circuits, \(C_{par}\), is measured using the same technique described in [25]. The value of \(C_{par}\) is then subtracted from the values of \(C_{max}\) and \(C_{min}\) to make them the net capacitance of the TENG. Therefore, the derived equations (1)–(7) below are insensitive to parasitic capacitance.

Since \(\Delta W_{i,HW}\) is a quadratic function of \(V_{C_i}\), there is an optimum \(V_{C_i}^{max}\) value in which the energy is maximum [22]:

\[
V_{C_i}^{max} = \frac{1}{2}V_{TE}(C_{max}/C_{min} - 1) - 1
\]

Then, the maximum converted energy is found as [22]:

\[
\Delta W_{max,HW} = \frac{1}{4}V_{TE}C_{min}(C_{max}/C_{min} - 1)^{\frac{3}{2}}
\]

For the case of full-wave rectifier the converted energy during \(i\)th cycle of operation is [22] (Section S2 of supporting information):

\[
\Delta W_{i,FW} = 2V_{C_i}C_{min}(C_{max}/C_{min} + 1)\left(V_{TE}C_{max}/C_{min} - 1 - V_{C_i}\right)
\]

and the value of \(V_{C_i}^{max}\) is found as [22]:

\[
V_{C_i}^{max} = \frac{1}{2}V_{TE}(C_{max}/C_{min} - 1) / (C_{max}/C_{min} + 1)
\]

Accordingly, the maximum converted energy is [22]:
The ratio of the maximum energy of the half-wave over full-wave conditioning circuit gives:
\[
\frac{\Delta W_{\text{max,HW}}}{\Delta W_{\text{max,FW}}} = \frac{C_{\text{max}}}{C_{\text{min}}} - 1
\]

(6)

Since \(C_{\text{max}} / C_{\text{min}} > 1\), it is observed that half-wave rectifier delivers a higher maximum energy to the load compared to full-wave rectifier.

### 3. Experimental results and discussion

According to Fig. 1a, a CS TENG is fabricated with a dielectric layer of PFA having 50 \(\mu\)m in thickness, relative permittivity of 2.1 and area of 10 \(\times\) 10 cm\(^2\). The TENG is actuated with 5 Hz frequency and is connected in turn to both conditioning circuits of Fig. 1b and c. The output voltage of \(V_C\) is measured through a high input-impedance follower.

A maximum contact force of 1.33 N is measured with the force sensor. \(C = 4.7\ nF\) for both circuits using 1N649 diodes with 835 V of measured breakdown voltage. Fig. 2 shows the measured charging curves of capacitance \(C\) for both conditioning circuits. Saturation values of \(V_C\) for half-wave and full-wave rectifiers are 165 V and 26 V respectively. Values of \(C_{\text{max}} = 692\ pF\), \(C_{\text{min}} = 144\ pF\) and \(V_{TE} = 43.42\ V\) are measured.

Fig. 3a shows the calculated energy per mechanical cycle delivered to the capacitance \(C\) according to equations (1) and (4), as well as the measured energy as a function of \(V_C\). Both theoretical and measured values verify that the half-wave rectifier delivers a higher maximum energy compared to the full-wave. It also shows that the measured and theoretical curves have a very good overlap for the value of \(V_C\) corresponding to the maximum energy. This value is measured as 81.2 V for the half-wave circuit and 12.42 V for the full-wave. Theoretical values from equations (2) and (5) would yield similar values as 82.49 and 14.22 for half-wave and full-wave respectively.

Theoretical curves in Fig. 3a along with equations (3) and (6) verify that the maximum converted energy is 0.98 \(\mu\)J and 0.33 \(\mu\)J for half-wave and full-wave rectifiers respectively. This results in a \(r_E = 2.96\) from equation (7). On the other hand, measured curves of Fig. 3a have their peaks of energy at 0.64 \(\mu\)J for the half-wave and 0.13 \(\mu\)J for the full-wave, which results in a ratio \(r_E = 4.92\). Therefore, both experimental and theoretical findings verify the superior performance of the half-wave rectifier over the full-wave when the harvested energy from a TENG is transferred to a capacitive load. It’s worth to notice that the deviation between measured energy and theoretical value comes mainly
from the assumption of ideal circuit elements. Especially, diodes consume energy in both forward and reverse modes for their normal operation, which would result in smaller delivered energy to the capacitance $C$.

Fig. 3b and c shows simulated QV cycles of TENG connected to both CC for the 2\textsuperscript{nd}, 6\textsuperscript{th}, 11\textsuperscript{th} and 201\textsuperscript{st} cycles. The area enclosed by each rectangle indicates the amount of energy delivered by the TENG to the rest of the circuit elements. Use of QV diagram is widespread for the purpose of comparison of output performance of TENG [7,26]. Fig. 3d compares the calculated delivered energy (enclosed area) of corresponding cycles in Fig. 3b and c. This figure also confirms that the TENG delivers a higher maximum energy when connected to the half-wave rectifier compared to full-wave.

4. Comparison of measured and simulated QV cycles

A new CS TENG similar to the device in section 3 is fabricated with smaller dimensions of $5 \times 5 \text{cm}^2$ and contact force of 0.2 N. Diodes in half-wave and full-wave circuits are replaced with very low leakage diodes of MMBD1501A type and $C = 4.7 \text{nF}$. QV cycles of the TENG are measured when connected to each CC. Due to memory limitation on the picocomparator (Keithley 6485) device, current and voltage of the TENG is recorded for only 30 seconds. Fig. 4a and b shows measured and simulated QV cycle of the TENG at 101\textsuperscript{st} cycle of operation corresponding to the time between 20S and 21S (corresponding to 5 Hz actuation frequency).

The measured and simulated QV cycles are divided into smaller rectangular in order to calculate the total area enclosed by each curve which corresponds to the converted energy by the TENG. Table 1 compares the results between half-wave and full-wave rectifiers.

Based on the results presented in Table 1, half-wave CC delivers a higher energy to the storage capacitance compared to full-wave CC.

5. Conclusion

Theoretical analysis is performed to compare the performance of half-wave and full-wave rectifiers as conditioning circuits for CS and LS mode TENG, and it is shown that half-wave circuit delivers a higher amount of energy per cycle to a capacitive load compared to full-wave. For both circuits, formulas for the calculation of optimum load voltage and maximum delivered energy are derived, which shows the better performance of the half-wave rectifier. QV cycles of the TENG for both CC are measured and compared with simulation results. Finally, experimental results indicate a very good agreement with the theories and verifies the superior performance of the half-wave rectifier over the full-wave.

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Appendix A. Supplementary data

Supplementary data to this article can be found online at https://doi.org/10.1016/j.nanoen.2019.104137.

References


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